## Notice of References Cited

1 3 8

Application/Control No.

O9/828,041

Examiner

Hong C Kim

Applicant(s)/Patent Under
Reexamination
HARGIS ET AL.

Page 1 of 2

#### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0147898	10-2002	Rentschler et al.	711/170
	В	US-2002/0147896	10-2002	Rentschler et al.	711/167
	С	US-2002/0147892	10-2002	Rentschler et al.	711/154
	D	US-2002/0140475	10-2002	Zumkehr et al.	327/170
	Е	US-2001/0046163	11-2001	Yanagawa, Miki	365/194
	F	US-2001/0022824	09-2001	Araki, Satoru	375/360
	G	US-6,532,525	03-2003	Aleksic et al.	711/168
	Η	US-6,496,889	12-2002	Perino et al.	710/110
	-	US-6,459,651	10-2002	Lee et al.	365/233
	J	US-6,370,630	04-2002	Mizuyabu et al.	711/167
	К	US-6,330,627	12-2001	Toda, Haruki	710/104
	L	US-6,230,245	05-2001	Manning, Troy A.	711/167
	М	US-5,899,570	05-1999	Darmawaskita et al.	374/170

#### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	P					
	α					
	R					
	S					·
	Т					

## **NON-PATENT DOCUMENTS**

	NON-I ATENT DOCUMENTO							
*	ļ	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U	Texas Instruments, CD4018B Counter, Data Sheet, 1998						
	v	Texas Instruments, SN5490 Counter, Data Sheet, 1988						
	w							
	x							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

14

## Notice of References Cited

<b>(</b>		
Application/Control No.		Patent Under
09/828,041	Reexaminati HARGIS ET	
Examiner	Art Unit	
Hong C Kim	2186	Page 2 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,710,800	01-1998	Ito, Masahiro	375/370
	В	US-4,970,418	11-1990	Masterson, Anthony D.	327/141
	С	US-4,759,043	07-1988	Lewis, Edward T.	377/116
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-	· .		
	М	US-			

## FOREIGN PATENT DOCUMENTS

				INEIGHT I ATEM DOG		
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0				111111111111111111111111111111111111111	
	Р					
	Q			1000000		
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)

**Notice of References Cited** 

4

Part of Paper No. 4

## Application/Control No. Notice of References Cited Application/Control No. 09/827,766 Examiner Hong C Kim Applicant(s)/Patent Under Reexamination RENTSCHLER ET AL. Page 1 of 1

#### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,532,525	03-2003	Aleksic et al.	711/168
	В	US-6,530,001	03-2003	Lee, Jung-Keun	711/154
Ш	С	US-2002/0172079	11-2002	Hargis et al.	365/193
M	D	US-2002/0147896	10-2002	Rentschler et al.	711/167
	Е	US-2002/0147892	10-2002	Rentschler et al.	711/154
	F	US-6,414,868	07-2002	Wong et al.	365/51
	G	US-6,370,630	04-2002	Mizuyabu et al.	711/167
	Н	US-2001/0046163	11-2001	Yanagawa, Miki	365/194
$\Box$	1	US-6,125,078	09-2000	Ooishi et al.	365/233
$\Box$	J	US-6,065,132	05-2000	Takano, Toshiya	713/600
Ш	Ķ	US-5,809,340	09-1998	Bertone et al.	710/58
4	L	US-5,727,005	03-1998	Le et al.	714/814
1/4	М	US-5,522,064	05-1996	Aldereguia et al.	713/501

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				:	
	0					
	P					
	σ			-		
	R	· .		-		
	Ø				,	
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

# Notice of References Cited Application/Control No. 09/827,768 Examiner Hong C Kim Applicant(s)/Patent Under Reexamination RENTSCHLER ET AL. Page 1 of 2

#### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0172079	11-2002	Hargis et al.	365/193
*	В	US-2002/0147898	10-2002	Rentschler et al.	711/170
*	C	US-2002/0147896	10-2002	Rentschler et al.	711/167
*	D	US-2001/0054135	12-2001	Matsuda, Yoichi	711/167
*	Е	US-2001/0003837	06-2001	Norman et al.	711/5
*	F	US-6,553,450	04-2003	Dodd et al.	711/105
*	G	US-6,532,525	03-2003	Aleksic et al.	711/168
*	H	US-6,530,001	03-2003	Lee, Jung-Keun	711/154
*	1	US-6,424,198	07-2002	Wolford, Barry Joe	327/291
*	J	US-6,370,630	04-2002	Mizuyabu et al.	711/167
*	K	US-6,324,119	11-2001	Kim, Chi-wook	365/233
*	L	US-6,144,598	11-2000	Cooper et al.	365/201
*	М	US-6,065,132	05-2000	Takano, Toshiya	713/600

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Ð					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

# Notice of References Cited Application/Control No. 09/828,604 Examiner Hong C Kim Applicant(s)/Patent Under Reexamination RENTSCHLER ET AL. Page 1 of 2

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0172079	11-2002	Hargis et al.	365/193
*	В	US-2002/0147898	10-2002	Rentschler et al.	711/170
*	С	US-2002/0147896	10-2002	Rentschler et al.	711/167
*	D	US-2001/0046163	11-2001	Yanagawa, Miki	365/194
*	E	US-6,532,525	03-2003	Aleksic et al.	711/168
*	F	US-6,530,001	03-2003	Lee, Jung-Keun	711/154
*	G	US-6,480,946	11-2002	Tomishima et al.	711/167
*	Н	US-6,370,630	04-2002	Mizuyabu et al.	711/167
*	1	US-6,338,113	01-2002	Kubo et al.	711/105
*	J	US-6,125,078	09-2000	Ooishi et al.	365/233
*	ĸ	US-6,065,132	05-2000	Takano, Toshiya	713/600
*	L	US-5,974,499	10-1999	Norman et al.	711/103
*	М	US-5,809,340	09-1998	Bertone et al.	710/58

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	<b>V</b>	
	8	
	x	

## 

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,727,005	03-1998	Le et al.	714/814
*	В	US-5,522,064	05-1996	Aldereguia et al.	713/501
	С	US-			
	D	US-			
	Е	US-			
	F	US-		·	
	G	US-			
١	н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2			,		
	0					
	Р					
	Q					· · · · · · · · · · · · · · · · · · ·
_	R		•			
	s			-		
	Т					

#### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

# Notice of References Cited Application/Control No. 09/827,768 Examiner Hong C Kim Applicant(s)/Patent Under Reexamination RENTSCHLER ET AL. Page 2 of 2

#### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,727,005	03-1998	Le et al.	714/814
*	В	US-5,701,438	12-1997	Bains, Kuljit S.	711/211
*	С	US-5,522,064	05-1996	Aldereguia et al.	713/501
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	ا ـ	US-			
	М	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					, , , , , , , , , , , , , , , , , , , ,
	Q.					
	ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	X	

